Applicant(s)/Patent Under Application/Control No. Reexamination 10/651,663 XIE, FEI Notice of References Cited Examiner Art Unit Page 1 of 1 Yuwen Pan 2682 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,839,108 11-1998 Daberko et al. 704/270 Α US-5,787,445 07-1998 Daberko, Norbert 707/205 В US-C US-D US-E US-F US-G US-H US-1 US-US-K US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date * Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

X